

**Notice of References Cited**

Application/Control No.

09/977,050

Applicant(s)/Patent Under  
Reexamination  
ELLIS ET AL.

Examiner

C. Michelle Tarae

Art Unit

3623

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	X	Finley, Eric et al. "Project Scheduling Risk Assessment Using Monte Carlo Methods," Cost Engineering, Oct 1994

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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